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**Wang**

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(54) **MULTI-LAYER CIRCUIT BOARD WITH  
WAVEGUIDE TO MICROSTRIP TRANSITION  
STRUCTURE**

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**H03H 5/00** (2006.01)  
**H01P 5/08** (2006.01)

(52) **U.S. Cl.**  
CPC ..... **H01P 5/087** (2013.01)

(58) **Field of Classification Search**  
USPC ..... 333/24 R, 25, 26, 204, 208, 238, 239  
See application file for complete search history.

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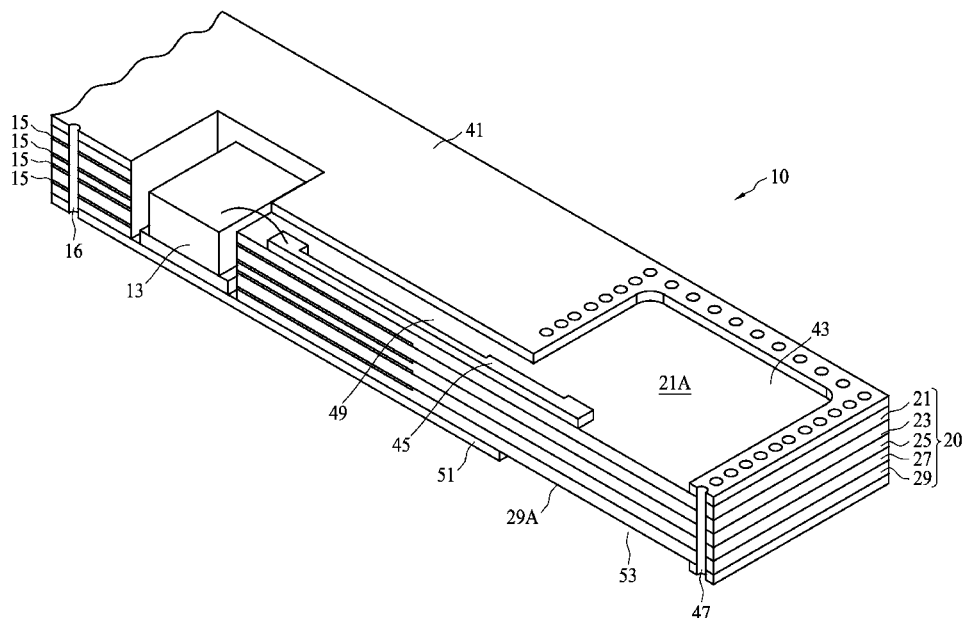
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(57) **ABSTRACT**

A multi-layer circuit board with a waveguide to microstrip transition structure includes a laminated structure having a plurality of dielectric layers, a top metal frame disposed over the laminated structure, a microstrip line disposed over the laminated structure, a bottom metal frame underlying the laminated structure, and a plurality of conductors electrically connecting the top metal frame and the bottom metal frame. The top metal frame defines a top cavity, the bottom metal frame defines a bottom cavity corresponding to the top cavity, and the microstrip line extends into the top cavity. The laminated structure includes an upper dielectric layer and at least one lower dielectric layer, wherein top cavity exposes a top surface of the upper dielectric layer, and the bottom cavity exposes a bottom surface of the at least one lower dielectric layer.

**19 Claims, 18 Drawing Sheets**



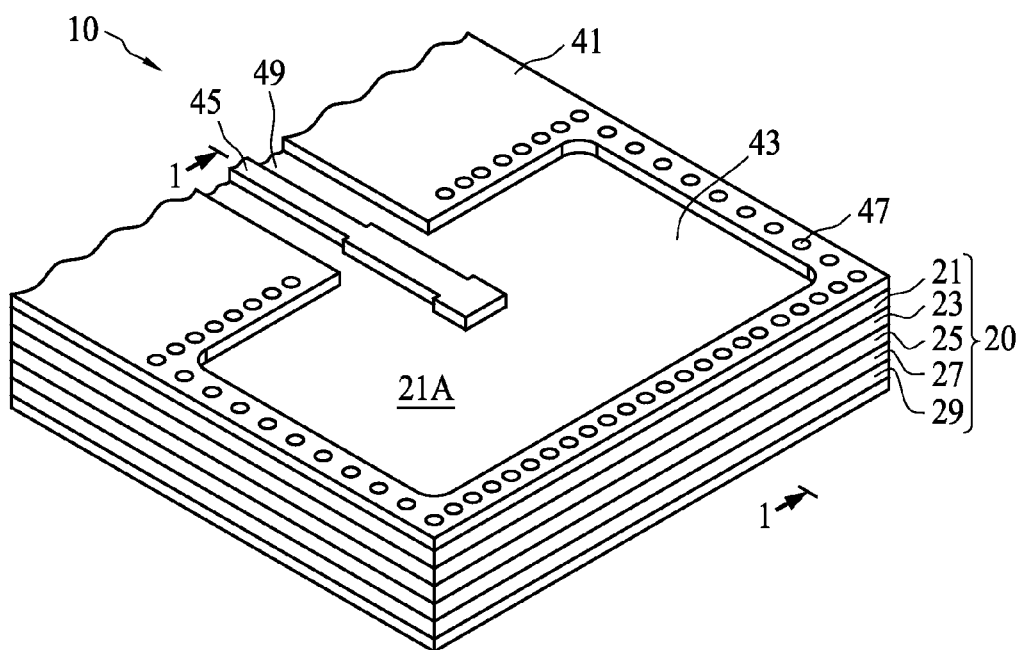


FIG. 1

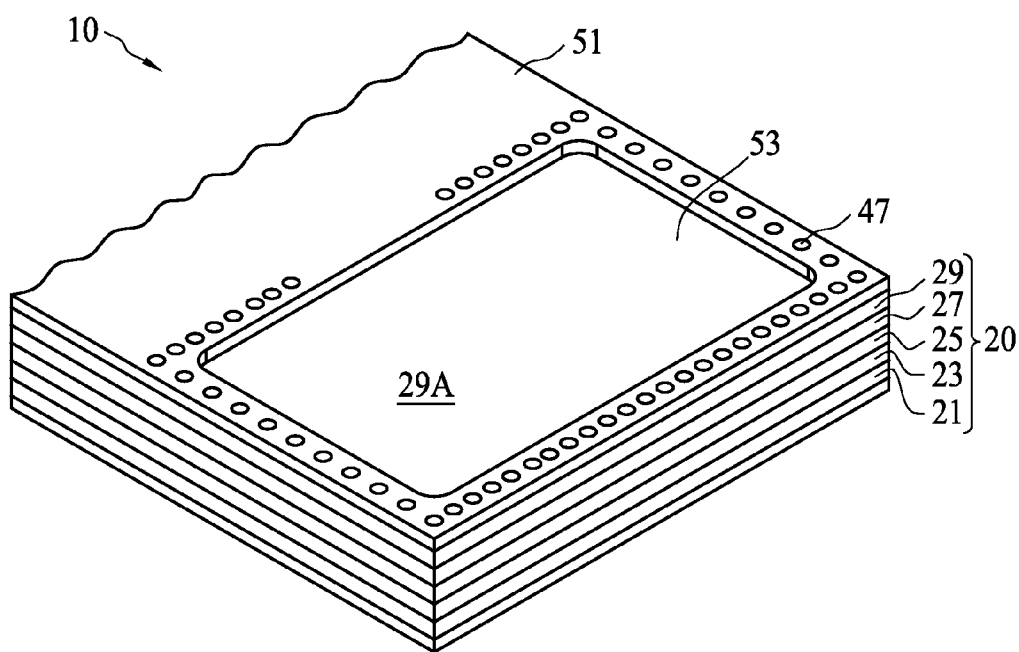


FIG. 2

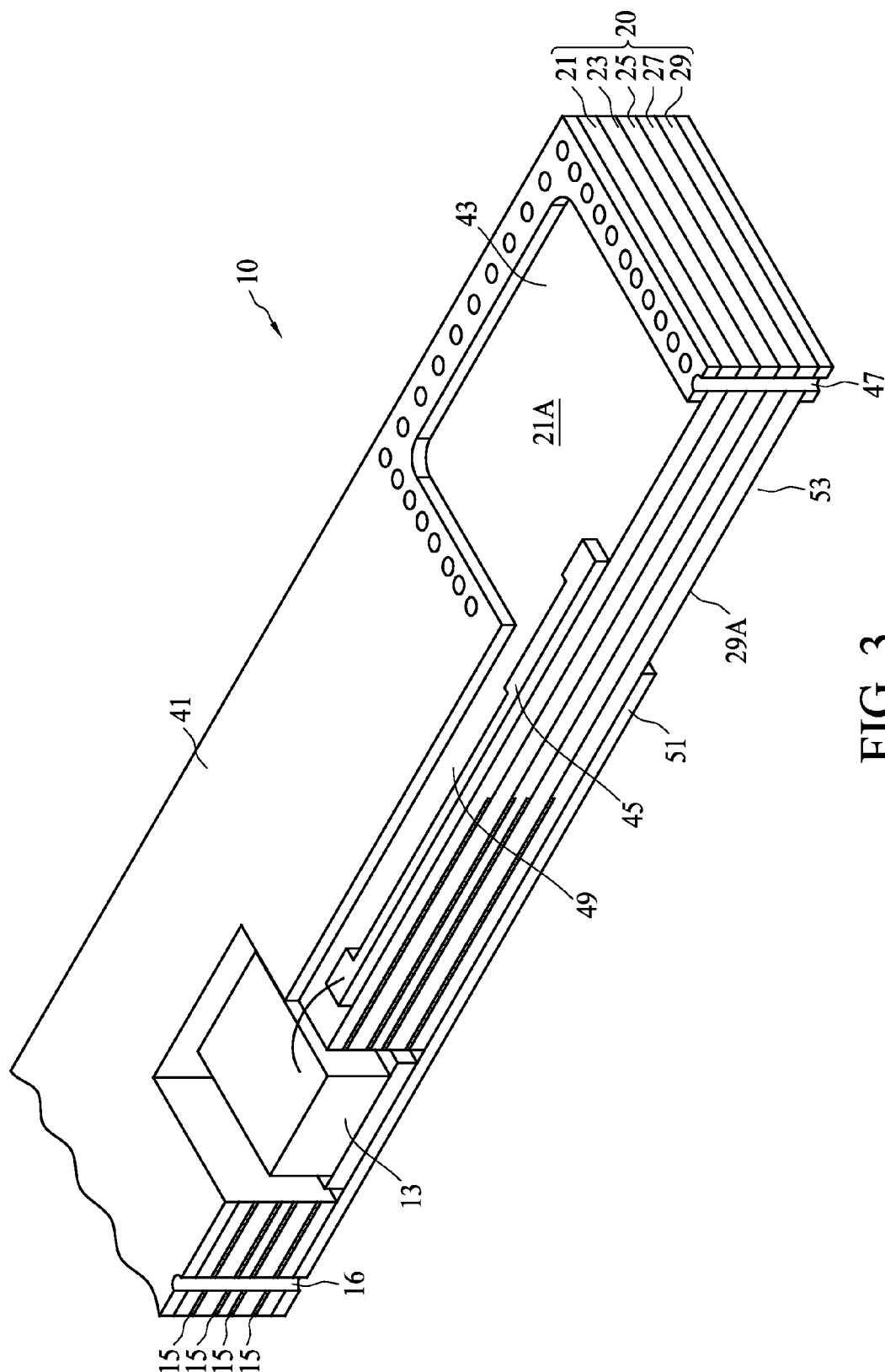


FIG. 3

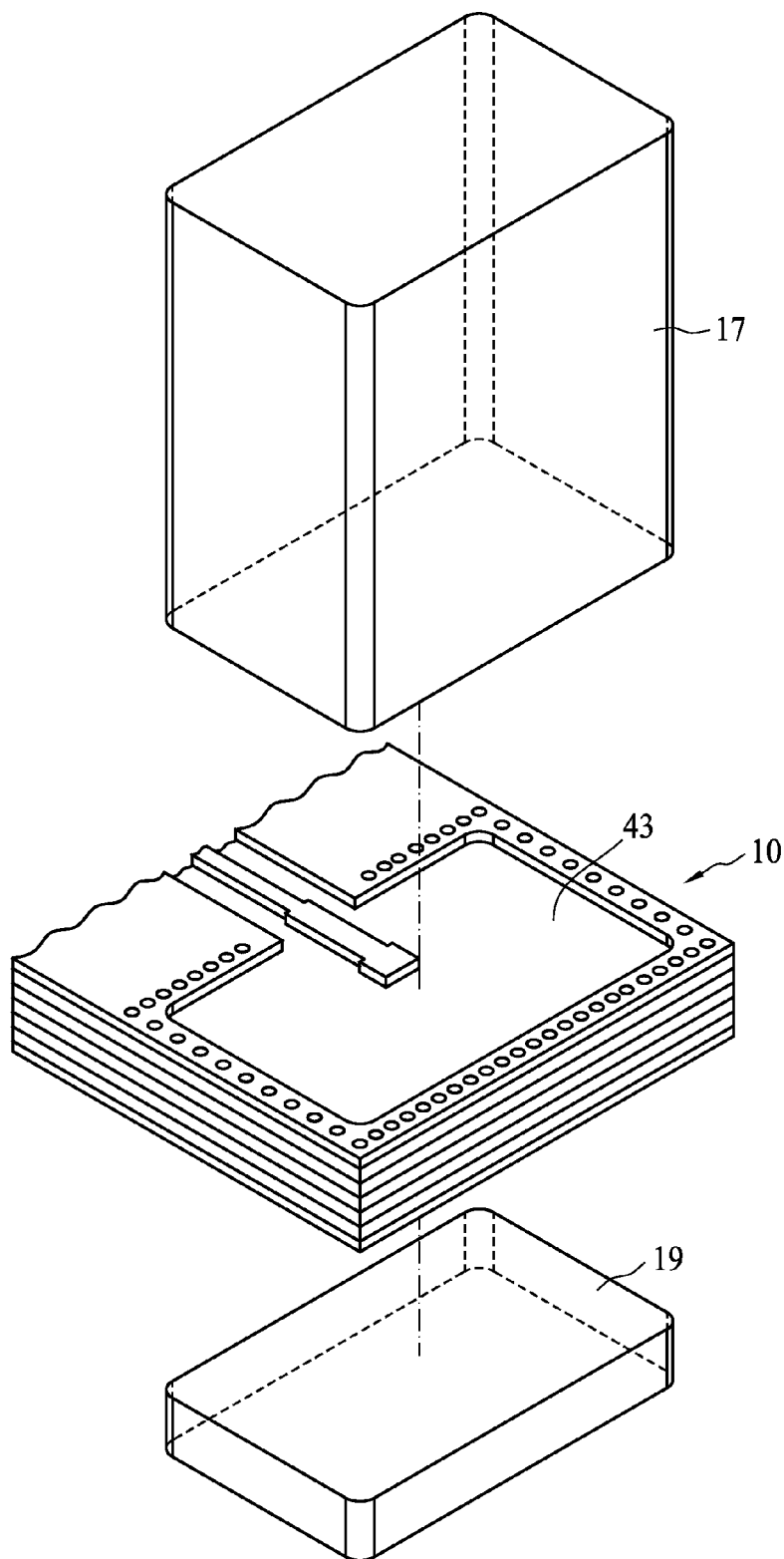


FIG. 4

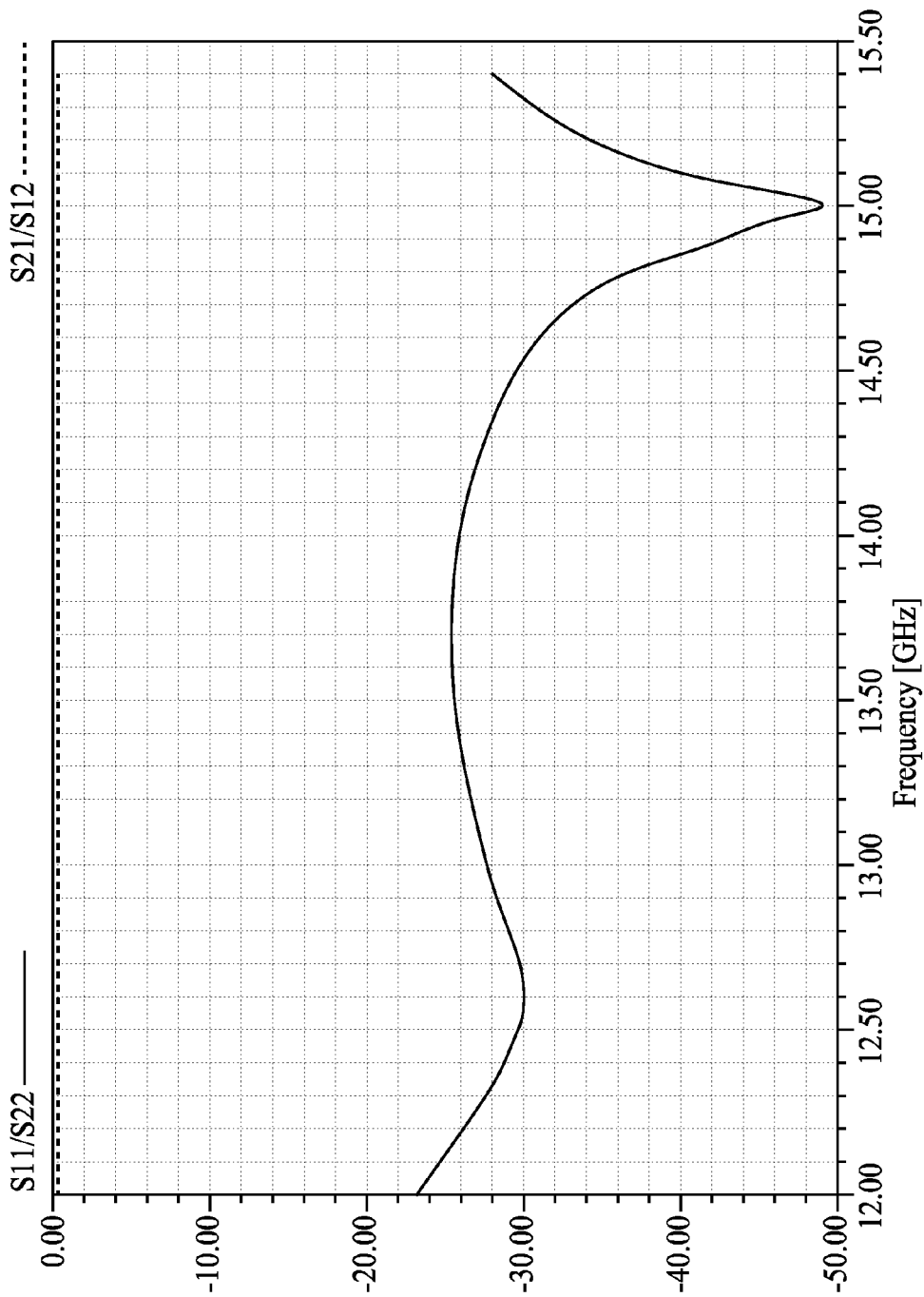


FIG. 5

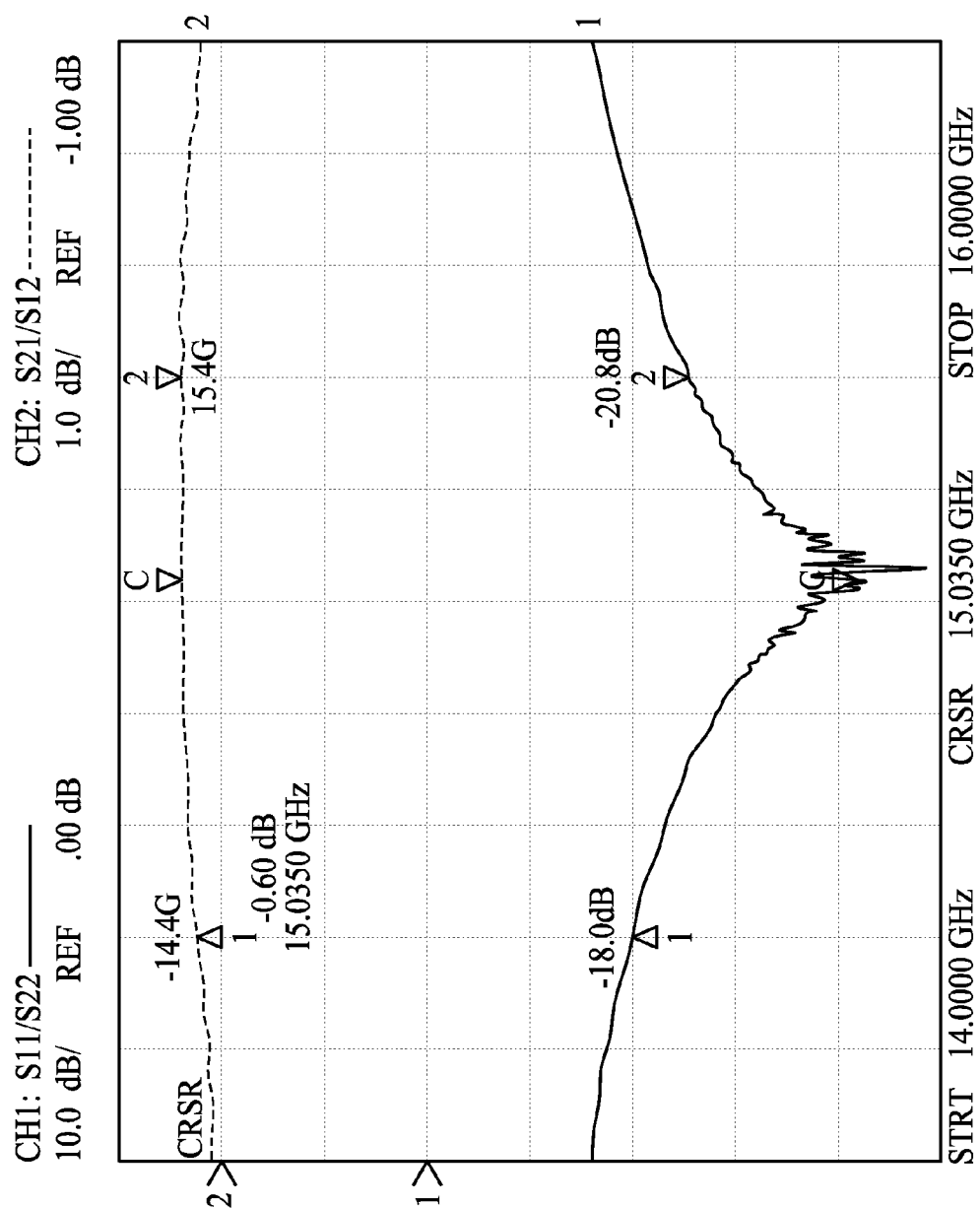


FIG. 6

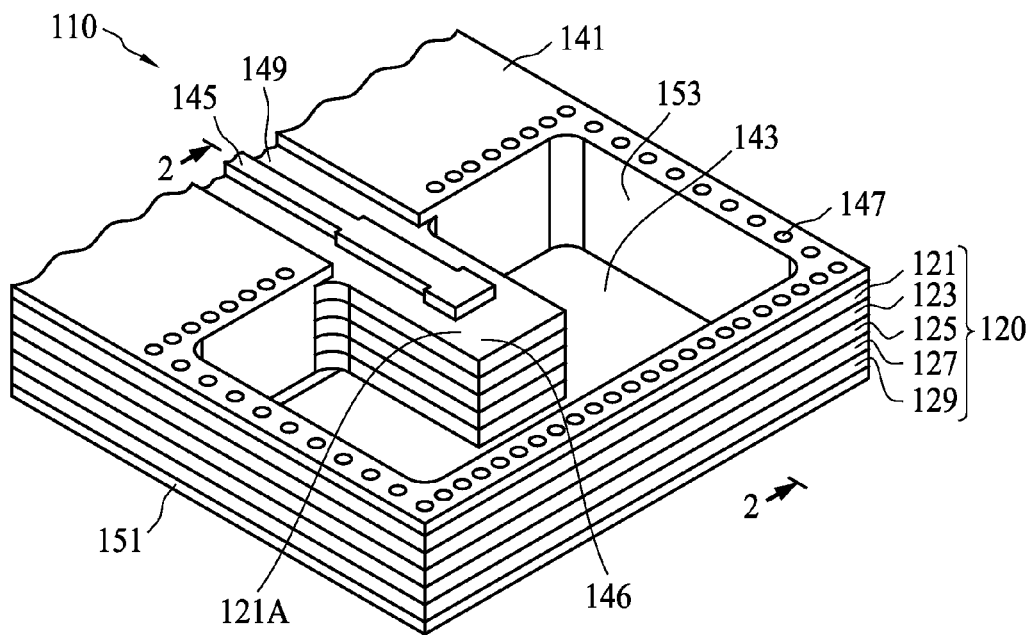


FIG. 7

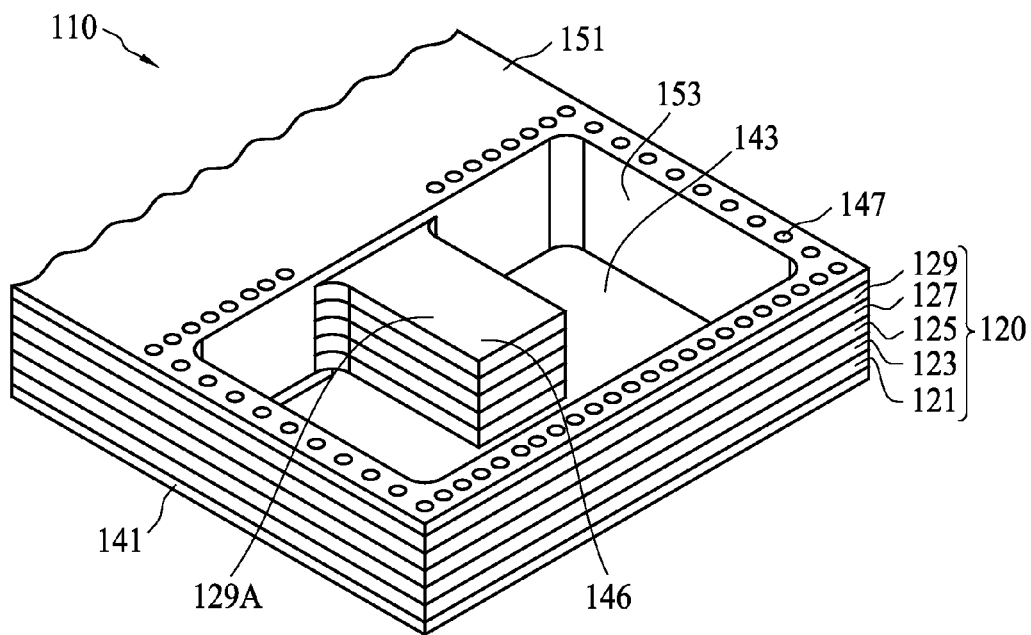


FIG. 8

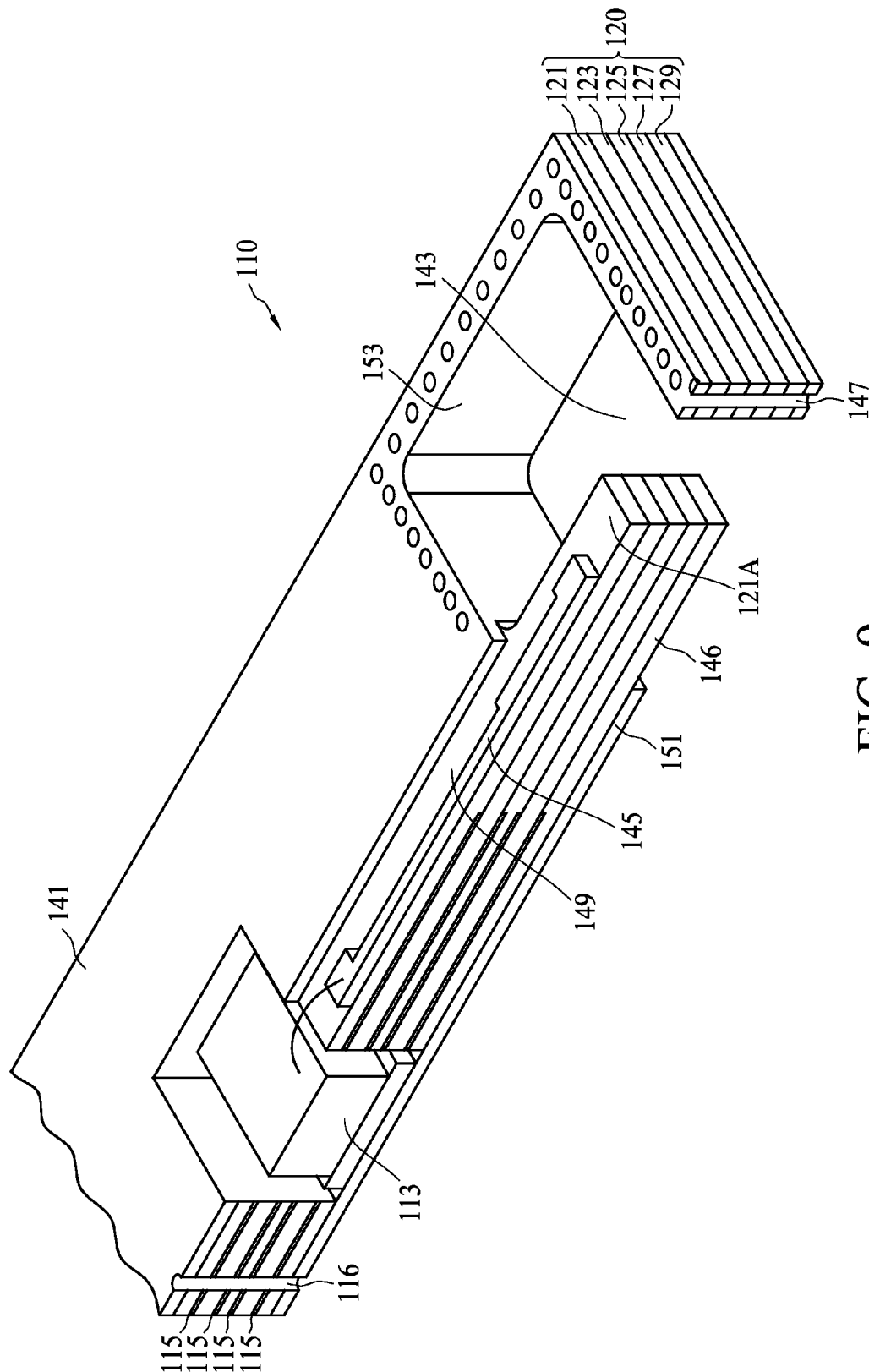


FIG. 9



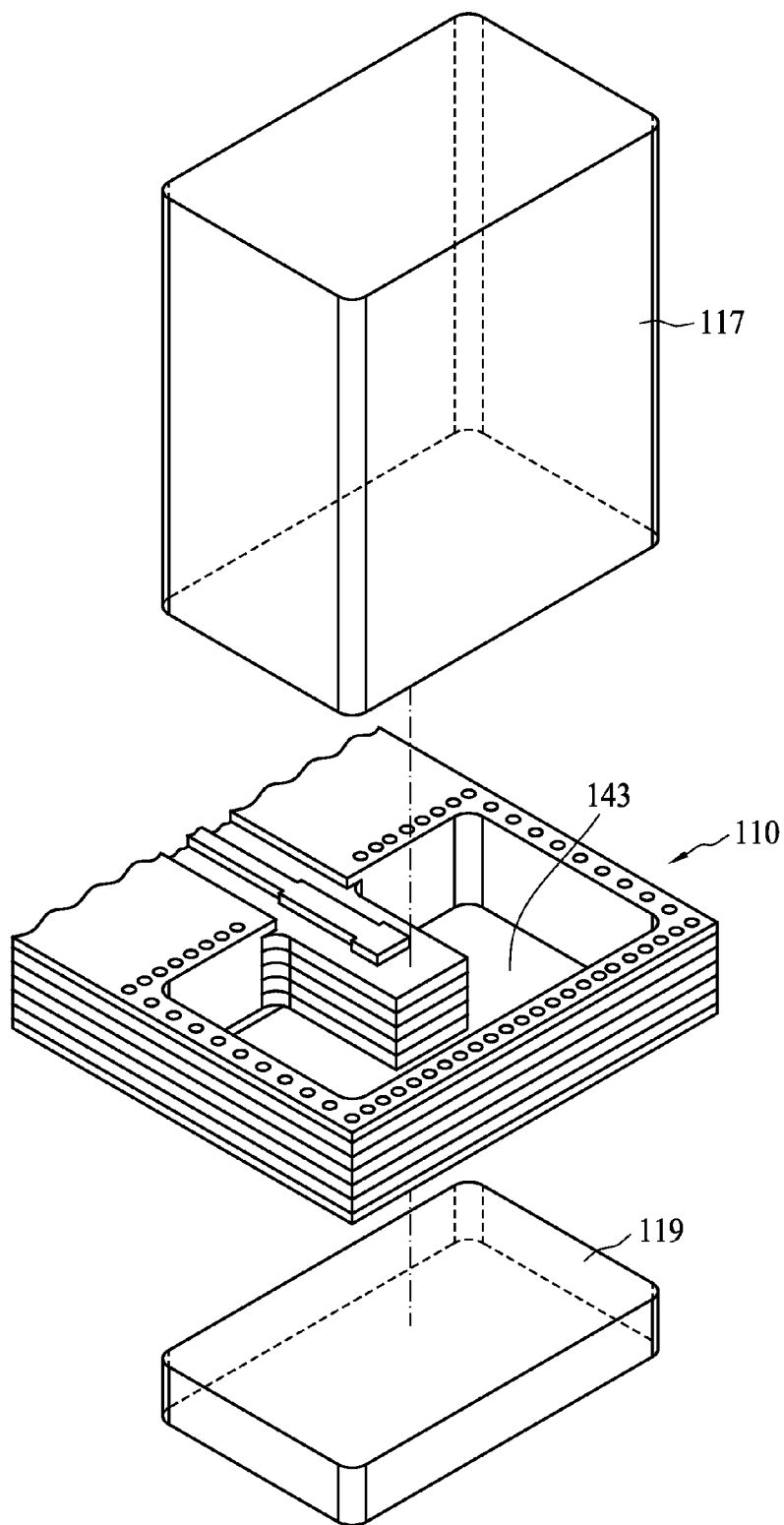


FIG. 10

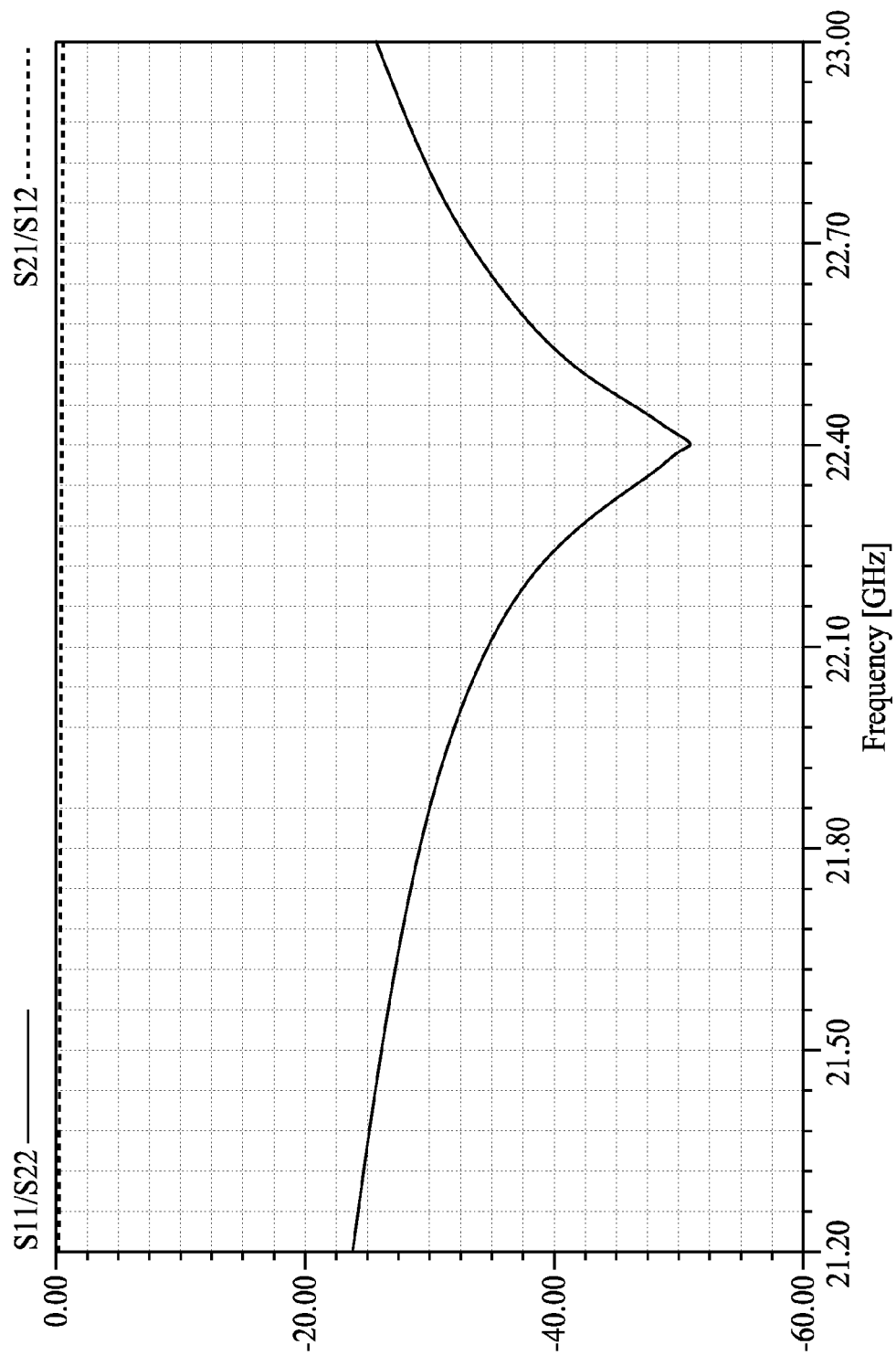


FIG. 11

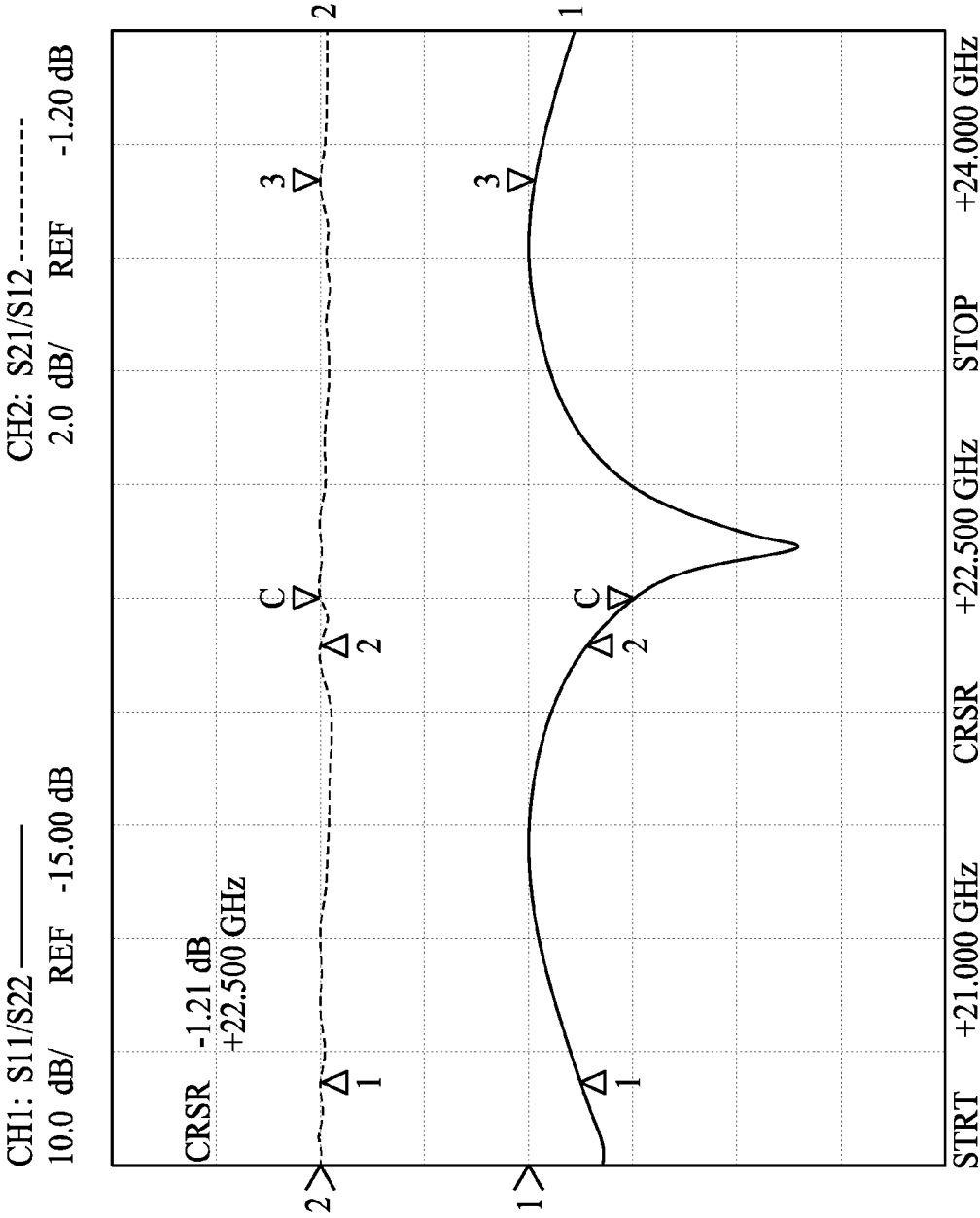


FIG. 12

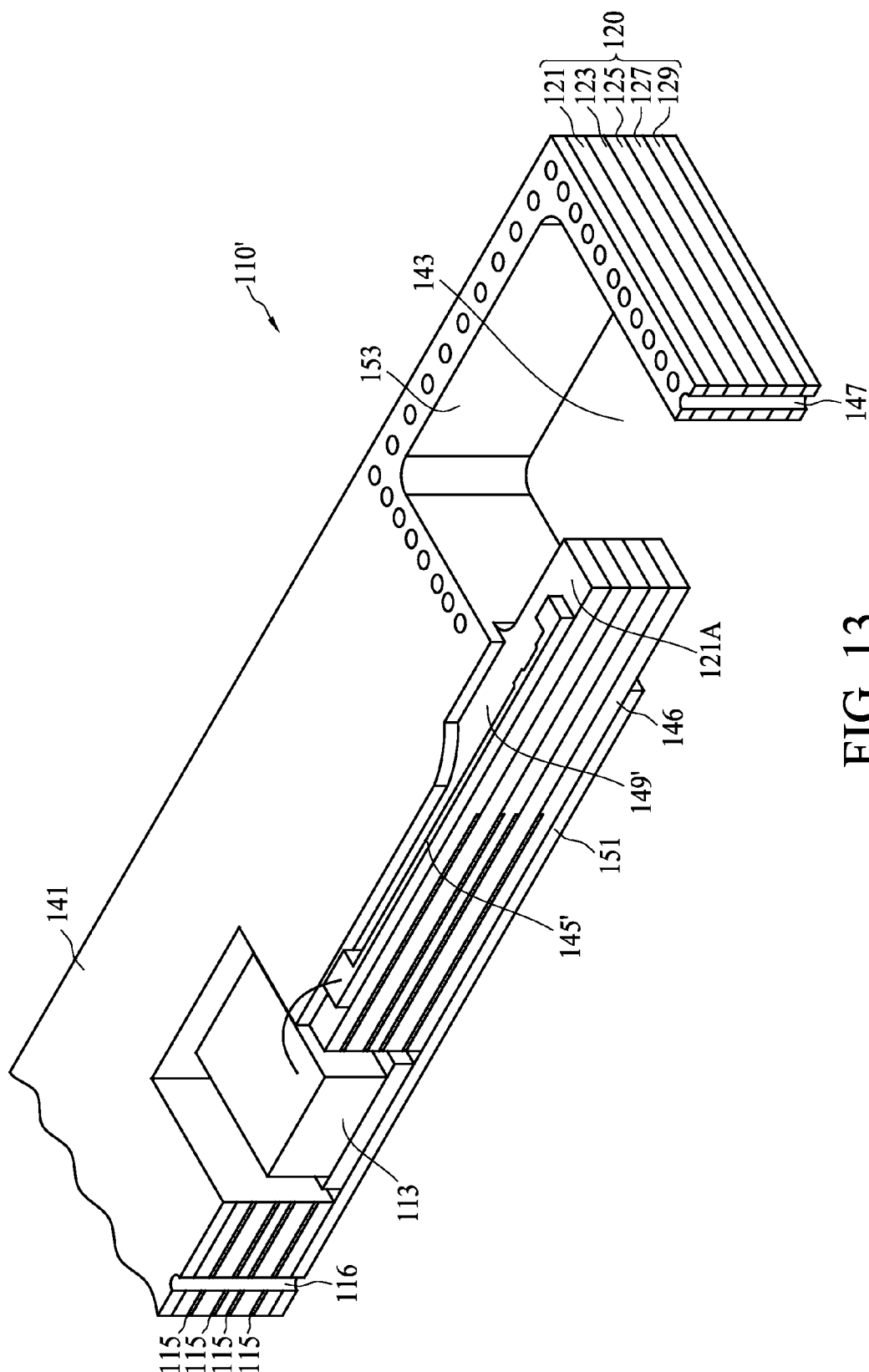


FIG. 13

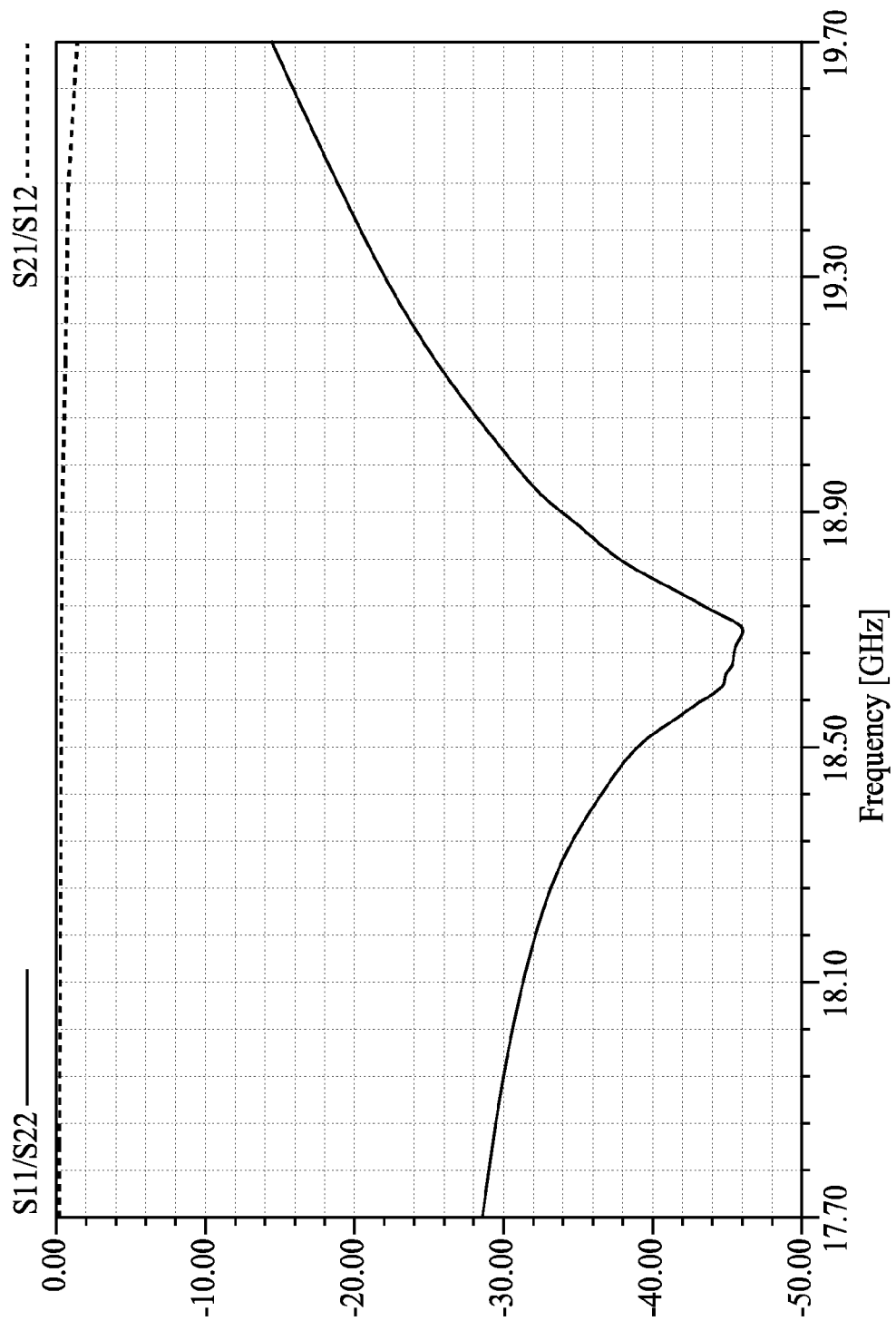


FIG. 14

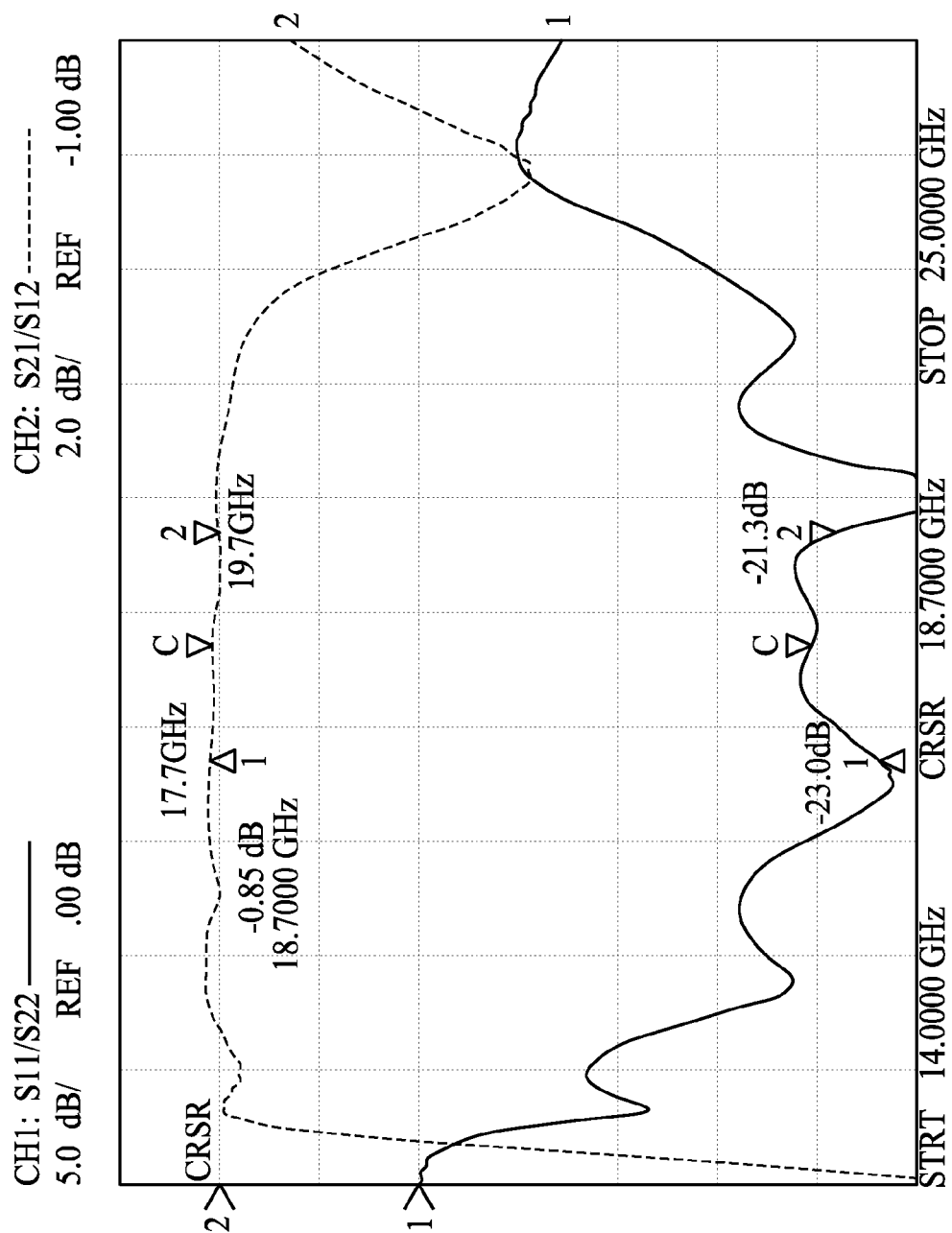


FIG. 15

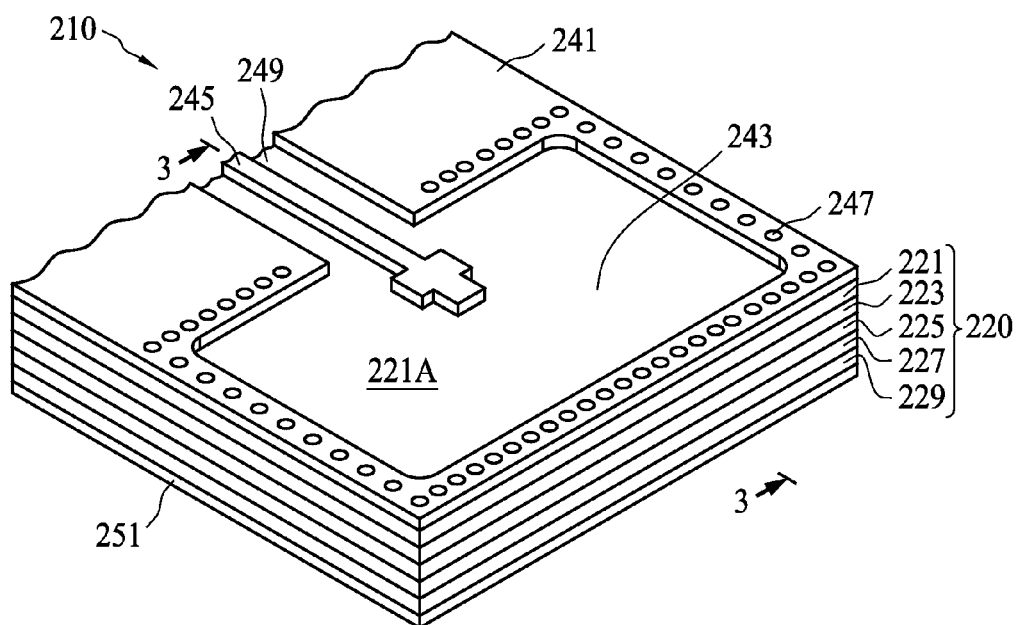


FIG. 16

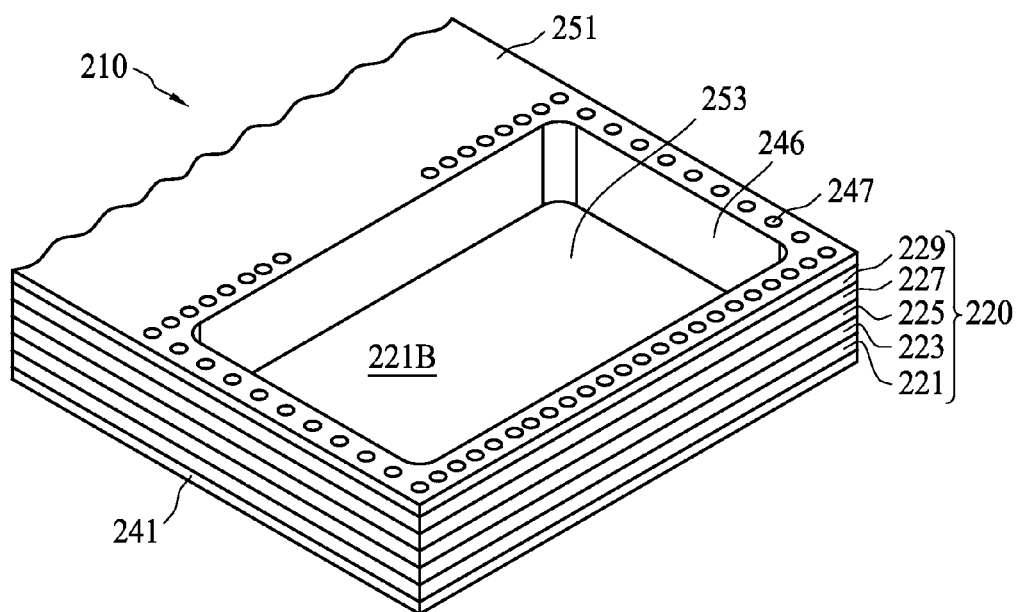


FIG. 17

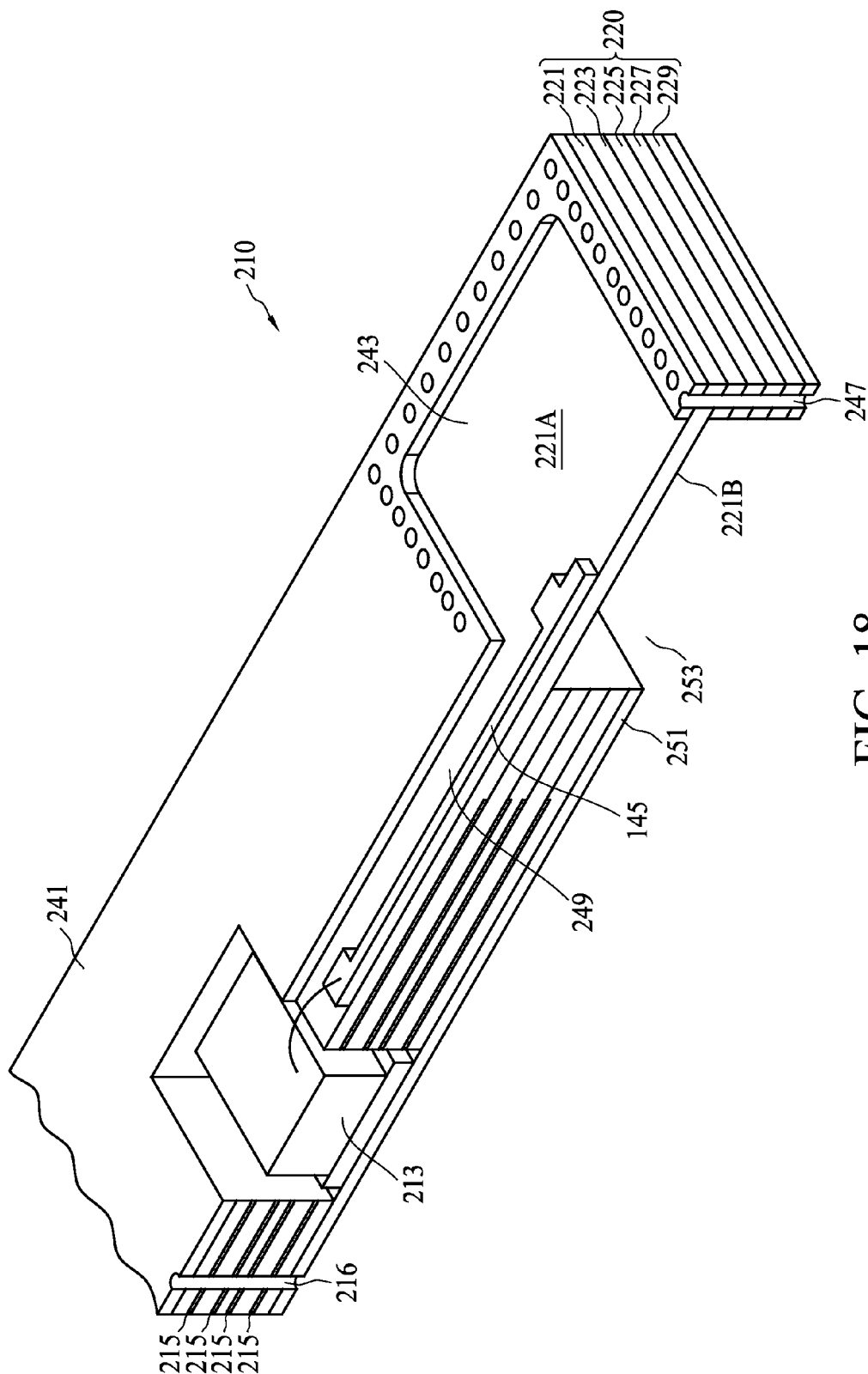


FIG. 18



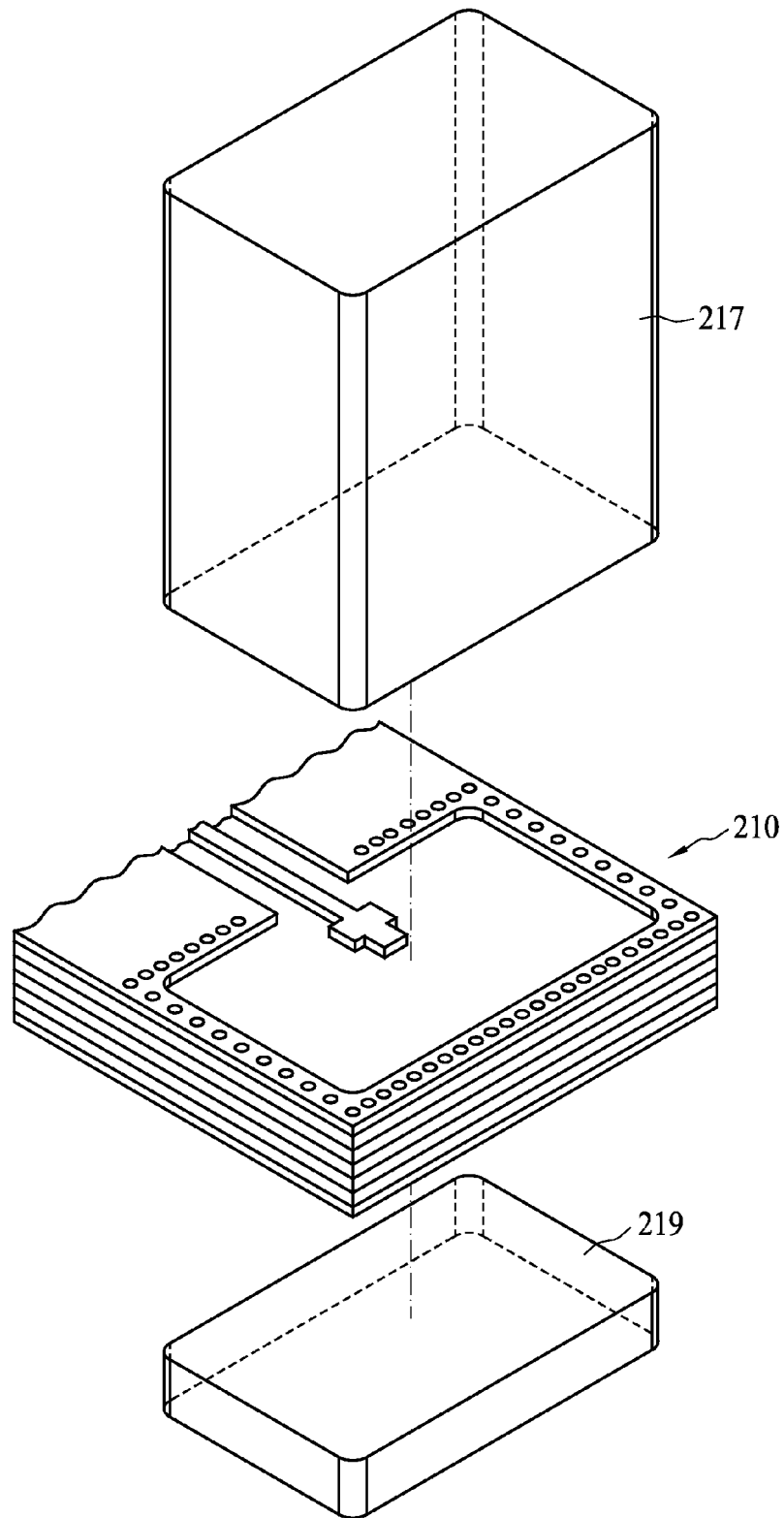


FIG. 19

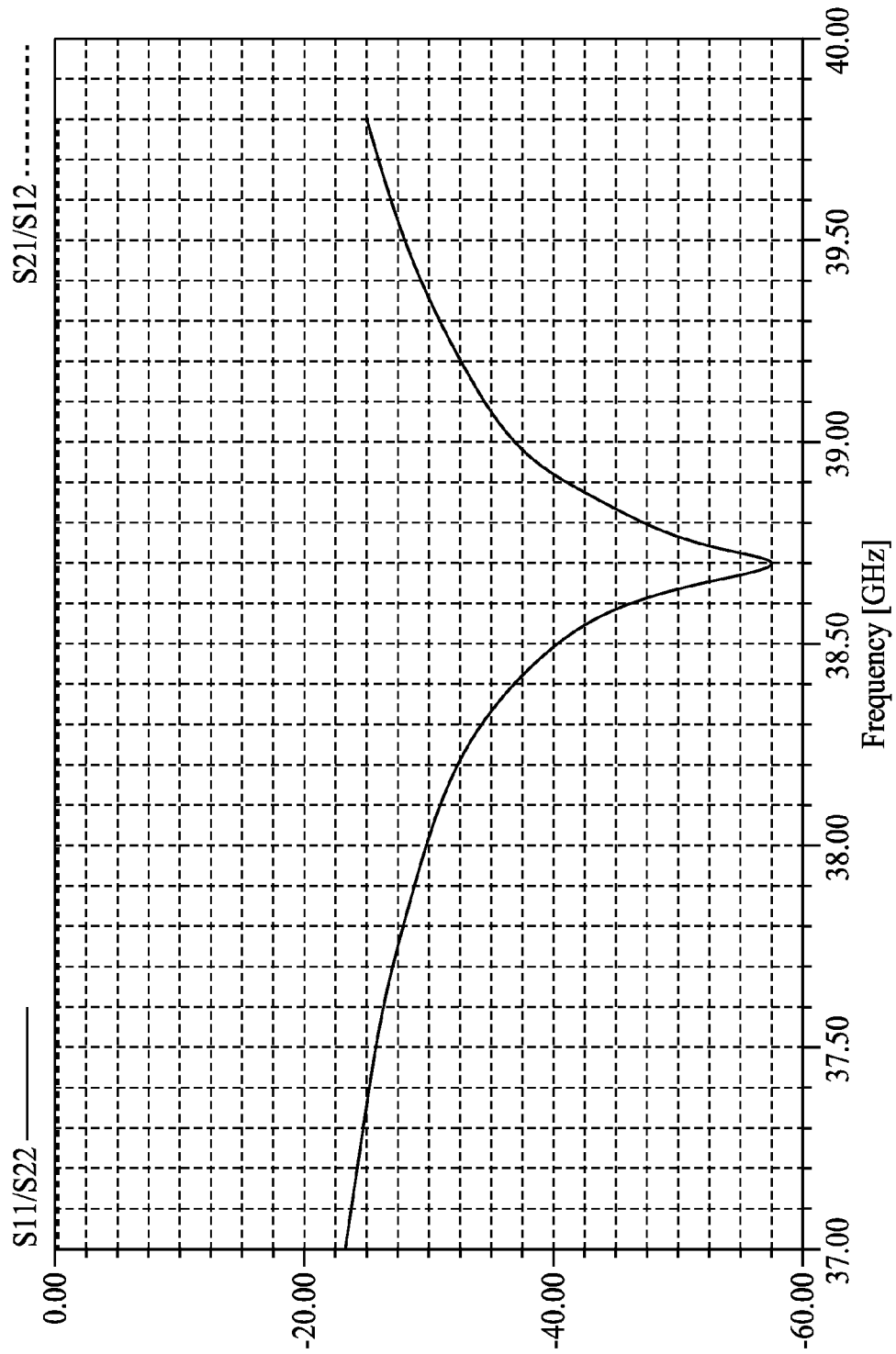


FIG. 20

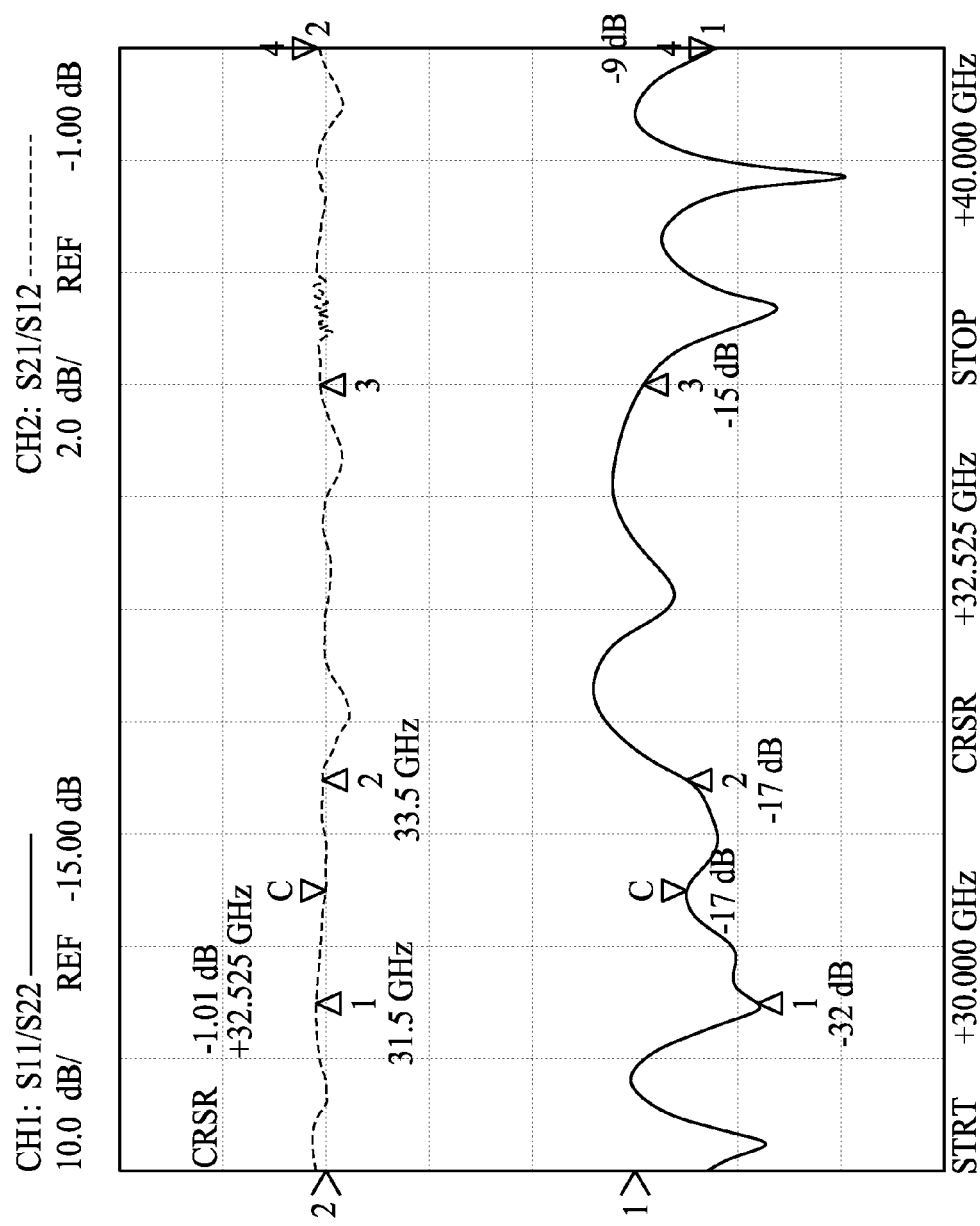


FIG. 21

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# MULTI-LAYER CIRCUIT BOARD WITH WAVEGUIDE TO MICROSTRIP TRANSITION STRUCTURE

## TECHNICAL FIELD

The present disclosure relates to a multi-layer circuit board, and more particularly, to a multi-layer circuit board with a waveguide to microstrip transition structure.

## DISCUSSION OF THE BACKGROUND

Microwave and millimeter wave circuits may use a combination of rectangular and/or circular waveguides and planar transmission lines such as striplines, microstrips, and coplanar waveguides. Waveguides are commonly used, for example, in antenna feed networks. Microwave circuit modules typically use microstrip transmission lines to interconnect microwave integrated circuits and semiconductor devices mounted on planar substrates. Transition devices are used to couple signals between microstrip transmission lines and waveguides.

This "Discussion of the Background" section is provided for background information only. The statements in this "Discussion of the Background" are not an admission that the subject matter disclosed in this "Discussion of the Background" section constitutes prior art to the present disclosure, and no part of this "Discussion of the Background" section may be used as an admission that any part of this application, including this "Discussion of the Background" section, constitutes prior art to the present disclosure.

## SUMMARY

One aspect of the present disclosure provides a multi-layer circuit board with a waveguide to microstrip transition structure.

According to some embodiments of the present disclosure, a multi-layer circuit board with a waveguide to microstrip transition structure comprises a laminated structure including a plurality of dielectric layers, a top metal frame disposed over the laminated structure, a microstrip line disposed over the laminated structure, a bottom metal frame underlying the laminated structure, and a plurality of conductors electrically connecting the top metal frame and the bottom metal frame. In some embodiments of the present disclosure, the top metal frame defines a top cavity, the bottom metal frame defines a bottom cavity corresponding to the top cavity, and the microstrip line extends into the top cavity. In an exemplary embodiment of the present disclosure, the laminated structure includes an upper dielectric layer and at least one lower dielectric layer, wherein the top cavity exposes a top surface of the upper dielectric layer, and the bottom cavity exposes a bottom surface of the at least one lower dielectric layer.

According to another embodiment of the present disclosure, a multi-layer circuit board with a waveguide to microstrip transition structure comprises a laminated structure including a plurality of dielectric layers, a top metal frame disposed over the laminated structure, a microstrip line disposed over the laminated structure, a bottom metal frame underlying the laminated structure, and a plurality of conductors electrically connecting the top metal frame and the bottom metal frame. In some embodiments of the present disclosure, the laminated structure has a waveguide cavity and a protrusion extending into the waveguide cavity, wherein the waveguide cavity penetrates through the laminated structure, and the microstrip line is disposed over the protrusion and

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extends into the waveguide cavity. In an exemplary embodiment of the present disclosure, the laminated structure includes an upper dielectric layer and at least one lower dielectric layer, wherein the waveguide cavity exposes a top surface of the upper dielectric layer of the protrusion and a bottom surface of the lower dielectric layer of the protrusion.

According to another embodiment of the present disclosure, a multi-layer circuit board with a waveguide to microstrip transition structure comprises a laminated structure including a plurality of dielectric layers, a top metal frame disposed over the laminated structure, a microstrip line disposed over the laminated structure, a bottom metal frame underlying the laminated structure, wherein the bottom metal frame defines a bottom cavity corresponding to the top cavity, and a plurality of conductors electrically connecting the top metal frame and the bottom metal frame. In some embodiments of the present disclosure, the top metal frame defines a top cavity, the bottom metal frame defines a bottom cavity corresponding to the top cavity, and the microstrip line is disposed over the laminated structure and extends into the top cavity. In an exemplary embodiment of the present disclosure, the laminated structure includes an upper dielectric layer and at least one lower dielectric layer, wherein the bottom cavity extends into the at least one lower dielectric layer and exposes a bottom surface of the upper dielectric layer.

The foregoing has outlined rather broadly the features and technical advantages of the present disclosure in order that the detailed description of the disclosure that follows may be better understood. Additional features and advantages of the disclosure will be described hereinafter, which form the subject of the claims of the disclosure. It should be appreciated by those skilled in the art that the conception and specific embodiment disclosed may be readily utilized as a basis for modifying or designing other structures or processes for carrying out the same purposes of the present disclosure. It should also be realized by those skilled in the art that such equivalent constructions do not depart from the spirit and scope of the disclosure as set forth in the appended claims.

## BRIEF DESCRIPTION OF THE DRAWINGS

A more complete understanding of the present disclosure may be derived by referring to the detailed description and claims when considered in connection with the Figures, where like reference numbers refer to similar elements throughout the Figures, and:

FIG. 1 is a top full view of a multi-layer circuit board with a waveguide to microstrip transition structure according to some embodiments of the present disclosure;

FIG. 2 is a bottom full view of the multi-layer circuit board in FIG. 1;

FIG. 3 is a distant cross-sectional view of the multi-layer circuit board along the cross-sectional line 1-1 in FIG. 1;

FIG. 4 is an exploded view of the multi-layer circuit board in FIG. 1 with other components;

FIG. 5 is a simulated frequency response diagram of the multi-layer circuit board with a waveguide to microstrip transition structure in FIG. 1;

FIG. 6 is a measured frequency response diagram of the multi-layer circuit board in FIG. 1;

FIG. 7 is a top full view of a multi-layer circuit board with a waveguide to microstrip transition structure according to some embodiments of the present disclosure;

FIG. 8 is a bottom full view of the multi-layer circuit board in FIG. 7;

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FIG. 9 is a distant cross-sectional view of the multi-layer circuit board along the cross-sectional line 2-2 in FIG. 7;

FIG. 10 is an exploded view of the multi-layer circuit board in FIG. 7 with other components;

FIG. 11 is a simulated frequency response diagram of the multi-layer circuit board with a waveguide to microstrip transition structure in FIG. 7;

FIG. 12 is a measured frequency response diagram of the multi-layer circuit board, as shown in FIG. 7;

FIG. 13 is a distant cross-sectional view of the multi-layer circuit board according to some embodiments of the present disclosure;

FIG. 14 is a simulated frequency response diagram of the multi-layer circuit board with a waveguide to microstrip transition structure in FIG. 13;

FIG. 15 is a measured frequency response diagram of the multi-layer circuit board in FIG. 13;

FIG. 16 is a top full view of a multi-layer circuit board with a waveguide to microstrip transition structure according to some embodiments of the present disclosure;

FIG. 17 is a bottom full view of the multi-layer circuit board in FIG. 16;

FIG. 18 is a distant cross-sectional view of the multi-layer circuit board along the cross-sectional line 3-3 in FIG. 16;

FIG. 19 is an exploded view of the multi-layer circuit board in FIG. 16 with other components;

FIG. 20 is a simulated frequency response diagram of the multi-layer circuit board with a waveguide to microstrip transition structure, as shown in FIG. 16; and

FIG. 21 is a measured frequency response diagram of the multi-layer circuit board in FIG. 16.

#### DETAILED DESCRIPTION

The following description of the disclosure accompanies drawings, which are incorporated in and constitute a part of this specification, and illustrate embodiments of the disclosure, but the disclosure is not limited to the embodiments. In addition, the following embodiments can be properly integrated to complete another embodiment.

References to “some embodiments,” “an embodiment,” “exemplary embodiment,” “other embodiments,” “another embodiment,” etc. indicate that the embodiment(s) of the disclosure so described may include a particular feature, structure, or characteristic, but not every embodiment necessarily includes the particular feature, structure, or characteristic. Further, repeated use of the phrase “in the embodiment” does not necessarily refer to the same embodiment, although it may.

The present disclosure is directed to a multi-layer circuit board with a waveguide to microstrip transition structure. In order to make the present disclosure completely comprehensible, detailed steps and structures are provided in the following description. Obviously, implementation of the present disclosure does not limit special details known by persons skilled in the art. In addition, known structures and steps are not described in detail, so as not to limit the present disclosure unnecessarily. Preferred embodiments of the present disclosure will be described below in detail. However, in addition to the detailed description, the present disclosure may also be widely implemented in other embodiments. The scope of the present disclosure is not limited to the detailed description, and is defined by the claims.

FIG. 1 is a top full view of a multi-layer circuit board 10 with a waveguide to microstrip transition structure according to some embodiments of the present disclosure, and FIG. 2 is a bottom full view of the multi-layer circuit board 10 in FIG.

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1. In some embodiments of the present disclosure, the multi-layer circuit board 10 comprises a laminated structure 20 including a plurality of dielectric layers 21-29, a top metal frame 41 disposed over the laminated structure 20, a microstrip line 45 disposed over the laminated structure 20, a bottom metal frame 51 underlying the laminated structure 20, and a plurality of conductors 47 electrically connecting the top metal frame 41 and the bottom metal frame 51.

In some embodiments of the present disclosure, the top metal frame 41 defines a top cavity 43, the bottom metal frame 51 defines a bottom cavity 53 corresponding to the top cavity 43, and the microstrip line 45 extends into the top cavity 43. In some embodiments of the present disclosure, the top metal frame 41 has a passage gap 49, and the microstrip line 45 extends into the top cavity 43 through the passage gap 49. In some embodiments of the present disclosure, the conductors 47 are conductive through holes which are either plated or filled with conductive material such as copper or copper alloy; in addition, other conductive material can also be used to form the conductors 47.

In an exemplary embodiment of the present disclosure, the top metal frame 41 and the bottom metal frame 51 may be formed of copper or copper alloy; in addition, other conductive material can also be used to form the top metal frame 41 and the bottom metal frame 51. In an exemplary embodiment of the present disclosure, the top metal frame 41 and the bottom metal frame 51 may have a thickness of 17.5 micrometers, which is commonly referred to as 0.5 oz copper.

In some embodiments of the present disclosure, the laminated structure 20 includes an upper dielectric layer 21 and a lower dielectric layer 29, wherein the upper dielectric layer 21 has a first dissipation factor, the lower dielectric layer 29 has a second dissipation factor, and the first dissipation factor is smaller than the second dissipation factor. For example, the upper dielectric layer 21 may use an RO4003C™ dielectric having a dissipation factor of 0.0027, which is commercially available from Rogers Corporation, or a TLY-5 dielectric having a dissipation factor of 0.0009, which is commercially available from Taconic International, Ltd, and the lower dielectric layer 29 may use epoxy-glass composite (FR4) material having a dissipation factor of 0.017. In a preferred embodiment of the present disclosure, the upper dielectric layer 21 is implemented by the RO4003C™ dielectric, and is considered inexpensive as compared to the TLY-5 dielectric.

In some embodiments of the present disclosure, the top cavity 43 exposes a top surface 21A of the upper dielectric layer 21, and the bottom cavity 53 exposes a bottom surface 29A of the lower dielectric layer 29. In an exemplary embodiment of the present disclosure, the upper dielectric layer 21 can be implemented by a sheet of an RO4003C™ dielectric having a thickness of 8.0 mil, and the lower dielectric layers 23-29 can be implemented by sheets of epoxy-glass composite (FR4) material having thicknesses from 4.7 mil to 8.0 mil.

FIG. 3 is a distant cross-sectional view of the multi-layer circuit board 10 along the cross-sectional line 1-1 in FIG. 1, showing the other portion of the multi-layer circuit board 10. In some embodiments of the present disclosure, the multi-layer circuit board 10 further comprises a plurality of metal layers 15 disposed between two of the plurality of dielectric layers 21-29. In an exemplary embodiment of the present disclosure, the metal layers 15 are electrically connected through conductors 16 such as conductive through holes which are either plated or filled with conductive material.

In some embodiments of the present disclosure, the multi-layer circuit board 10 further comprises an electronic device 13 electrically connected to the microstrip line 45 or at least one of the metal layers 15. In an exemplary embodiment of

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the present disclosure, the electronic device **13** is an RF signal processing circuit, a power amplifier, or a filter. In addition, the electronic device **13** may electrically connect to another device (not shown in the drawings) disposed on the multi-layer circuit board **10** through the metal layers **15** and the conductive members **16**. In an exemplary embodiment of the present disclosure, the metal layers **15** may have a thickness of 17.5 micrometers (commonly referred to as 0.5 oz copper) or a thickness of 35.0 micrometers (commonly referred to as 1.0 oz copper).

FIG. 4 is an exploded view of the multi-layer circuit board **10** in FIG. 1 with other components. In some embodiments of the present disclosure, the multi-layer circuit board **10** may be assembled with a waveguide **17** coupled to the top cavity **43** and a wave reflector **19** coupled to the bottom cavity **53**. In an exemplary embodiment of the present disclosure, the waveguide **17** may use a WR-62 waveguide.

FIG. 5 is a simulated frequency response diagram of the multi-layer circuit board **10** with a waveguide to microstrip transition structure, as shown in FIG. 1, and FIG. 6 is a measured frequency response diagram of the multi-layer circuit board **10**, as shown in FIG. 1, in which the transverse axis represents the frequency and the longitudinal axis represents the insertion loss (solid line) or return loss (dotted line). Comparing FIG. 5 and FIG. 6, it is clear that the simulated frequency response diagram is substantially the same as that of the measured frequency response diagram. As shown in FIG. 5 and FIG. 6, according to some embodiments of the present disclosure, the center frequency of the multi-layer circuit board **10** is designed to be about 15.0 GHz, wherein the return loss is optimized and the insertion loss is very low, at about 0.4 dB.

FIG. 7 is a top full view of a multi-layer circuit board **110** with a waveguide to microstrip transition structure according to some embodiments of the present disclosure, and FIG. 8 is a bottom full view of the multi-layer circuit board **110** in FIG. 7. In some embodiments of the present disclosure, the multi-layer circuit board **110** comprises a laminated structure **120** including a plurality of dielectric layers **121-129**, a top metal frame **141** disposed over the laminated structure **120**, a microstrip line **145** disposed over the laminated structure **120**, a bottom metal frame **151** underlying the laminated structure **120**, and a plurality of conductors **147** electrically connecting the top metal frame **141** and the bottom metal frame **151**. In an exemplary embodiment of the present disclosure, the conductors **147** are conductive through holes which are either plated or filled with conductive material such as copper or copper alloy; in addition, other conductive material can also be used to form the conductors **147**.

In some embodiments of the present disclosure, the laminated structure **120** has a waveguide cavity **143** and a protrusion **146** extending into the waveguide cavity **143**, and the waveguide cavity **143** penetrates through the laminated structure **120**. In some embodiments of the present disclosure, the microstrip line **145** is disposed over the protrusion **146** and extends into the waveguide cavity **143**. In some embodiments of the present disclosure, the top metal frame **141** has a passage gap **149**, and the microstrip line **145** extends into the top cavity **143** through the passage gap **149**.

In some embodiments of the present disclosure, the sidewalls of the waveguide cavity **143** are plated with a conductive plating **153**; further, the sidewalls of the protrusion **146** are not plated with conductive material, and the corners between the sidewall of the waveguide cavity **143** and the sidewall of the protrusion **146** are not plated with conductive material. In an exemplary embodiment of the present disclosure, the conductive plating **153** may be formed of copper or

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copper alloy; in addition, other conductive material can also be used to form the conductive plating **153**.

In an exemplary embodiment of the present disclosure, the top metal frame **141** and the bottom metal frame **151** may be formed of copper or copper alloy; in addition, other conductive material can also be used to form the top metal frame **141** and the bottom metal frame **151**. In an exemplary embodiment of the present disclosure, the top metal frame **141** and the bottom metal frame **151** may have a thickness of 17.5 micrometers, which is commonly referred to as 0.5 oz copper.

In some embodiments of the present disclosure, the laminated structure **120** includes an upper dielectric layer **121** and a lower dielectric layer **129**, wherein the upper dielectric layer **121** has a first dissipation factor, the lower dielectric layer **129** has a second dissipation factor, and the first dissipation factor is smaller than the second dissipation factor. For example, the upper dielectric layer **121** may use an RO4003C™ dielectric having a dissipation factor of 0.0027, which is commercially available from Rogers Corporation, or a TLY-5 dielectric having a dissipation factor of 0.0009, which is commercially available from Taconic International, Ltd, and the lower dielectric layer **129** may use epoxy-glass composite (FR4) material having a dissipation factor of 0.017. In a preferred embodiment of the present disclosure, the upper dielectric layer **21** is implemented by the RO4003C™ dielectric, and is considered inexpensive as compared to the TLY-5 dielectric.

In some embodiments of the present disclosure, the waveguide cavity **143** exposes a top surface **121A** of the upper dielectric layer **121** of the protrusion **146** and a bottom surface **129A** of the lower dielectric layer **129** of the protrusion **146**. In an exemplary embodiment of the present disclosure, the upper dielectric layer **121** can be implemented by a sheet of an RO4003C™ dielectric having a thickness of 8.0 mil, and the lower dielectric layers **123-129** can be implemented by sheets of epoxy-glass composite (FR4) material having thicknesses from 4.7 mil to 8.0 mil.

FIG. 9 is a distant cross-sectional view of the multi-layer circuit board **110** along the cross-sectional line 2-2 in FIG. 7, showing the other portion of the multi-layer circuit board **110**. In some embodiments of the present disclosure, the multi-layer circuit board **110** further comprises a plurality of metal layers **115** each disposed between two of the plurality of dielectric layers **121-129**. In an exemplary embodiment of the present disclosure, the metal layers **115** are electrically connected through conductive members **116** such as conductive through holes which are either plated or filled with conductive material.

In some embodiments of the present disclosure, the multi-layer circuit board **110** further comprises an electronic device **113** electrically connected to the microstrip line **145** or at least one of the metal layers **115**. In an exemplary embodiment of the present disclosure, the electronic device **113** is an RF signal processing circuit, a power amplifier, or a filter. In addition, the electronic device **113** may electrically connect to another device (not shown in the drawings) disposed on the multi-layer circuit board **110** through the metal layers **115** and the conductive members **116**. In an exemplary embodiment of the present disclosure, the metal layers **115** may have a thickness of 17.5 micrometers (commonly referred to as 0.5 oz copper) or a thickness of 35.0 micrometers (commonly referred to as 1.0 oz copper).

FIG. 10 is an exploded view of the multi-layer circuit board **110** in FIG. 7 with other components. In some embodiments of the present disclosure, the multi-layer circuit board **110** may be assembled with a waveguide **117** coupled to the top of the waveguide cavity **143** and a wave reflector **119** coupled to

the bottom of the waveguide cavity **143**. In an exemplary embodiment of the present disclosure, the waveguide **117** may use a WR-42 waveguide.

FIG. **11** is a simulated frequency response diagram of the multi-layer circuit board **110** with a waveguide to microstrip transition structure, as shown in FIG. **7**, and FIG. **12** is a measured frequency response diagram of the multi-layer circuit board **110**, as shown in FIG. **7**, in which the transverse axis represents the frequency and the longitudinal axis represents the insertion loss (solid line) or return loss (dotted line). Comparing FIG. **11** and FIG. **12**, it is clear that the simulated frequency response diagram is substantially the same as that of the measured frequency response diagram. As shown in FIG. **11** and FIG. **12**, according to some embodiments of the present disclosure, the center frequency of the multi-layer circuit board **110** is designed to be about 22.5 GHz, wherein the return loss is optimized and the insertion loss is very low, at about 1.0 dB.

FIG. **13** is a distant cross-sectional view of the multi-layer circuit board **110'** according to some embodiments of the present disclosure. Comparing the multi-layer circuit board **110'** in FIG. **13** and the multi-layer circuit board **110** in FIG. **9**, it is clear that the shape of the microstrip line **145'** in FIG. **11** is different from that of the microstrip line **145** in FIG. **9**, and the shape of the passage gap **149'** in FIG. **11** is different from that of the passage gap **149** in FIG. **9**.

FIG. **14** is a simulated frequency response diagram of the multi-layer circuit board **110'** with a waveguide to microstrip transition structure, as shown in FIG. **13**, and FIG. **15** is a measured frequency response diagram of the multi-layer circuit board **110'**, as shown in FIG. **13**, in which the transverse axis represents the frequency and the longitudinal axis represents the insertion loss (solid line) or return loss (dotted line). Comparing FIG. **14** and FIG. **15**, it is clear that the simulated frequency response diagram is substantially the same as that of the measured frequency response diagram. As shown in FIG. **14** and FIG. **15**, according to some embodiments of the present disclosure, the center frequency of the multi-layer circuit board **110'** is designed to be about 18.0 GHz, wherein the return loss is optimized and the insertion loss is very low, at about 0.6 dB.

The structure of the multi-layer circuit board **110'** is substantially the same as that of the multi-layer circuit board **110**, except for the shape of the microstrip line and the shape of the passage gap. In other words, the structure design of the present disclosure can be used to design the multi-layer circuit board with a waveguide to microstrip transition structure for different frequency application by changing the shape of the microstrip line and the shape of the passage gap.

FIG. **16** is a top full view of a multi-layer circuit board **210** with a waveguide to microstrip transition structure according to some embodiments of the present disclosure, and FIG. **17** is a bottom full view of the multi-layer circuit board **210** in FIG. **16**. In some embodiments of the present disclosure, the multi-layer circuit board **210** comprises a laminated structure **220** including a plurality of dielectric layers **221-229**, a top metal frame **241** disposed over the laminated structure **220**, a microstrip line **245** disposed over the laminated structure **220**, a bottom metal frame **251** underlying the laminated structure **220**, and a plurality of conductors **247** electrically connecting the top metal frame **241** and the bottom metal frame **251**. In an exemplary embodiment of the present disclosure, the conductors **247** are conductive through holes which are either plated or filled with conductive material such as copper or copper alloy; in addition, other conductive material can also be used to form the conductors **247**.

In some embodiments of the present disclosure, the top metal frame **241** defines a top cavity **243**, the bottom metal frame **251** defines a bottom cavity **253** corresponding to the top cavity **243**, and the microstrip line **245** extends into the top cavity **243**. In some embodiments of the present disclosure, the top metal frame **241** has a passage gap **249**, and the microstrip line **245** extends into the top cavity **243** through the passage gap **249**. In some embodiments of the present disclosure, the conductors **247** are conductive through holes which are either plated or filled with conductive material such as copper or copper alloy; in addition, other conductive material can also be used to form the conductors **247**. In some embodiments of the present disclosure, the sidewalls of the bottom cavity **253** are plated with a conductive plating **246**. In an exemplary embodiment of the present disclosure, the conductive plating **246** may be formed of copper or copper alloy; in addition, other conductive material can also be used to form the conductive plating **246**.

In an exemplary embodiment of the present disclosure, the top metal frame **241** and the bottom metal frame **251** may be formed of copper or copper alloy; in addition, other conductive material can also be used to form the top metal frame **241** and the bottom metal frame **251**. In an exemplary embodiment of the present disclosure, the top metal frame **241** and the bottom metal frame **251** may have a thickness of 17.5 micrometers, which is commonly referred to as 0.5 oz copper.

In some embodiments of the present disclosure, the laminated structure **220** includes an upper dielectric layer **221** and a lower dielectric layer **229**, wherein the upper dielectric layer **221** has a first dissipation factor, the lower dielectric layer **229** has a second dissipation factor, and the first dissipation factor is smaller than the second dissipation factor. For example, the upper dielectric layer **221** may use a TLY-5 dielectric having a dissipation factor of 0.0009, which is commercially available from Taconic International, Ltd, and the lower dielectric layer **229** may use epoxy-glass composite (FR4) material having a dissipation factor of 0.017.

In some embodiments of the present disclosure, the top cavity **243** exposes a top surface **221A** of the upper dielectric layer **221**, and the bottom cavity **253** exposes a bottom surface **221B** of the upper dielectric layer **221**. In an exemplary embodiment of the present disclosure, the upper dielectric layer **221** can be implemented by a sheet of a TLY-5 dielectric having a thickness of 10.0 mil, and the lower dielectric layers **223-229** can be implemented by sheets of epoxy-glass composite (FR4) material having thicknesses from 4.7 mil to 8.0 mil.

FIG. **18** is a distant cross-sectional view of the multi-layer circuit board **210** along the cross-sectional line 3-3 in FIG. **16**, showing the other portion of the multi-layer circuit board **210**. In some embodiments of the present disclosure, the multi-layer circuit board **210** further comprises a plurality of metal layers **215** each disposed between two of the plurality of dielectric layers **221-229**. In an exemplary embodiment of the present disclosure, the metal layers **215** are electrically connected through conductive members **216** such as conductive through holes which are either plated or filled with conductive material.

In some embodiments of the present disclosure, the multi-layer circuit board **210** further comprises an electronic device **213** electrically connected to the microstrip line **245** or one of the metal layers **215**. In an exemplary embodiment of the present disclosure, the electronic device **213** is an RF signal processing circuit, a power amplifier, or a filter. In addition, the electronic device **213** may electrically connect to another device (not shown in the drawings) disposed on the multi-layer circuit board **210** through the metal layers **215** and the

conductive members **216**. In an exemplary embodiment of the present disclosure, the metal layers **215** may have a thickness of 17.5 micrometers (commonly referred to as 0.5 oz copper) or a thickness of 35.0 micrometers (commonly referred to as 1.0 oz copper).

FIG. **19** is an exploded view of the multi-layer circuit board **210** in FIG. **16** with other components. In some embodiments of the present disclosure, the multi-layer circuit board **210** may be assembled with a waveguide **217** coupled to the top cavity **243** and a wave reflector **219** coupled to the bottom cavity **253**. In an exemplary embodiment of the present disclosure, the waveguide **127** may use a WR-28 waveguide.

FIG. **20** is a simulated frequency response diagram of the multi-layer circuit board **210** with a waveguide to microstrip transition structure, as shown in FIG. **16**, and FIG. **21** is a measured frequency response diagram of the multi-layer circuit board **210**, as shown in FIG. **16**, in which the transverse axis represents the frequency and the longitudinal axis represents the insertion loss (solid line) or return loss (dotted line). Comparing FIG. **20** and FIG. **21**, it is clear that the simulated frequency response diagram is substantially the same as that of the measured frequency response diagram. As shown in FIG. **20** and FIG. **21**, according to some embodiments of the present disclosure, the center frequency of the multi-layer circuit board **210** is designed to be about 38.75 GHz, wherein the return loss is optimized and the insertion loss is very low, at about 0.3 dB.

Although the present disclosure and its advantages have been described in detail, it should be understood that various changes, substitutions and alterations can be made herein without departing from the spirit and scope of the disclosure as defined by the appended claims. For example, many of the processes discussed above can be implemented in different methodologies and replaced by other processes, or a combination thereof.

Moreover, the scope of the present application is not intended to be limited to the particular embodiments of the process, machine, manufacture, composition of matter, means, methods and steps described in the specification. As one of ordinary skill in the art will readily appreciate from the disclosure of the present disclosure, processes, machines, manufacture, compositions of matter, means, methods, or steps, presently existing or later to be developed, that perform substantially the same function or achieve substantially the same result as the corresponding embodiments described herein may be utilized according to the present disclosure. Accordingly, the appended claims are intended to include within their scope such processes, machines, manufacture, compositions of matter, means, methods, or steps.

What is claimed is:

1. A multi-layer circuit board with a waveguide to microstrip transition structure, comprising:
  - a laminated structure including a plurality of dielectric layers;
  - a top metal frame disposed over the laminated structure, wherein the top metal frame defines a top cavity;
  - a microstrip line disposed over the laminated structure and extending into the top cavity;
  - a bottom metal frame underlying the laminated structure, wherein the bottom metal frame defines a bottom cavity corresponding to the top cavity; and
  - a plurality of conductors electrically connecting the top metal frame and the bottom metal frame;
 wherein the laminated structure includes an upper dielectric layer and at least one lower dielectric layer, the top cavity exposes a top surface of the upper dielectric layer,

and the bottom cavity exposes a bottom surface of the at least one lower dielectric layer.

2. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **1**, wherein the upper dielectric layer has a first dissipation factor, the at least one lower dielectric layer has a second dissipation factor, and the first dissipation factor is smaller than the second dissipation factor.

3. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **1**, wherein the top metal frame has a passage gap, and the microstrip line extends into the top cavity through the passage gap.

4. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **1**, further comprising an electronic device electrically connected to the microstrip line.

5. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **1**, further comprising a plurality of metal layers disposed between two of the plurality of dielectric layers.

6. A multi-layer circuit board with a waveguide to microstrip transition structure, comprising:

- a laminated structure including a plurality of dielectric layers, wherein the laminated structure has a waveguide cavity and a protrusion extending into the waveguide cavity, and the waveguide cavity penetrates through the laminated structure;

- a top metal frame disposed over the laminated structure;

- a microstrip line disposed over the laminated structure and extending into the waveguide cavity;

- a bottom metal frame underlying the laminated structure; and

- a plurality of conductors electrically connecting the top metal frame and the bottom metal frame;

- wherein the laminated structure includes an upper dielectric layer and at least one lower dielectric layer, and the waveguide cavity exposes a top surface of the upper dielectric layer of the protrusion and a bottom surface of the at least one lower dielectric layer of the protrusion.

7. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **6**, wherein the laminated structure includes an upper dielectric layer having a first dissipation factor, at least one lower dielectric layer having a second dissipation factor, and the first dissipation factor is smaller than the second dissipation factor.

8. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **6**, wherein the top metal frame has a passage gap, and the microstrip line extends into the waveguide cavity through the passage gap.

9. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **6**, further comprising an electronic device electrically connected to the microstrip line.

10. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **6**, further comprising a plurality of metal layers disposed between two of the plurality of dielectric layers.

11. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **6**, further comprising a conductive plating disposed on sidewalls of the waveguide cavity.

12. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **11**, wherein sidewalls of the protrusion are not plated with the conductive plating.

13. The multi-layer circuit board with a waveguide to microstrip transition structure of claim **11**, wherein corners



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between the sidewall of the waveguide cavity and the sidewall of the protrusion are not plated with conductive plating.

**14.** A multi-layer circuit board with a waveguide to microstrip transition structure, comprising:

- a laminated structure including a plurality of dielectric layers;
  - a top metal frame disposed over the laminated structure, wherein the top metal frame defines a top cavity;
  - a microstrip line disposed over the laminated structure and extending into the top cavity;
  - a bottom metal frame underlying the laminated structure, wherein the bottom metal frame defines a bottom cavity corresponding to the top cavity; and
  - a plurality of conductors electrically connecting the top metal frame and the bottom metal frame;
- wherein the laminated structure includes an upper dielectric layer and at least one lower dielectric layer, and the bottom cavity extends into the at least one lower dielectric layer and exposes a bottom surface of the upper dielectric layer.

**15.** The multi-layer circuit board with a waveguide to microstrip transition structure of claim **14**, wherein the upper

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dielectric layer has a first dissipation factor, the at least one lower dielectric layer has a second dissipation factor, and the first dissipation factor is smaller than the second dissipation factor.

**16.** The multi-layer circuit board with a waveguide to microstrip transition structure of claim **14**, wherein the top metal frame has a passage gap, and the microstrip line extends into the top cavity through the passage gap.

**17.** The multi-layer circuit board with a waveguide to microstrip transition structure of claim **14**, further comprising an electronic device electrically connected to the microstrip line.

**18.** The multi-layer circuit board with a waveguide to microstrip transition structure of claim **14**, further comprising a plurality of metal layers disposed between two of the plurality of dielectric layers.

**19.** The multi-layer circuit board with a waveguide to microstrip transition structure of claim **14**, further comprising a conductive plating disposed on sidewalls of the bottom cavity.

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